

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/628,511	CHANG ET AL.	
	Examiner	Art Unit	Page 1 of 1
	Kanji Patel	2624	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,068,843 B2	06-2006	Chang et al.	382/203
*	B	US-5,454,043	09-1995	Freeman, William T.	382/168
	C	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages
	U	Mokhtarian et al. (" Robust and Efficient Shape Indexing through Curvature Scale Space", 1996, Dept. of Electrical Engineering, University of Surrey, England).
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.